DATA SHEET



BIPOLAR ANALOG INTEGRATED CIRCUIT $\mu PC2710T$

5 V, MINIMOLD SILICON MMIC MEDIUM OUTPUT POWER AMPLIFIER

DESCRIPTION

The μ PC2710T is a silicon monolithic integrated circuits designed as PA driver for 900 MHz band cellular telephone tuners. This IC is packaged in minimold package.

This IC is manufactured using NEC's 20 GHz fr NESAT™ III silicon bipolar process. This process uses silicon nitride passivation film and gold electrodes. These materials can protect chip surface from external pollution and prevent corrosion/migration. Thus, this IC has excellent performance, uniformity and reliability.

FEATURES

• Supply voltage : Vcc = 4.5 to 5.5 V

Wideband response
 : fu = 1.0 GHz TYP. @ 3 dB bandwidth

Medium output power
 Po(sat) = +13.5 dBm TYP. @ f = 500 MHz with external inductor

Power gain : GP = 33 dB TYP. @ f = 500 MHz

• Port impedance : input/output 50 Ω

APPLICATION

• PA driver for PDC900M

ORDERING INFORMATION

Part Number	Package	Marking	Supplying Form
μPC2710T-E3	6-pin minimold	C1F	Embossed tape 8 mm wide. 1, 2, 3 pins face to perforation side of the tape. Qty 3 kp/reel

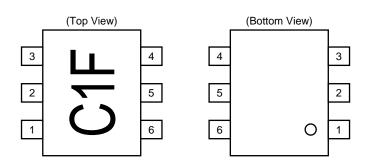
Remark To order evaluation samples, please contact your local NEC sales office. (Part number for sample order: μ PC2710T)

Caution Electro-static sensitive devices

The information in this document is subject to change without notice.



PIN CONNECTIONS



Pin No.	Pin Name			
1	INPUT			
2	GND			
3	GND			
4	OUTPUT			
5	GND			
6	Vcc			

PRODUCT LINE-UP OF μ PC2710 (TA = +25°C, Vcc = Vout = 5.0 V, ZL = Zs = 50 Ω)

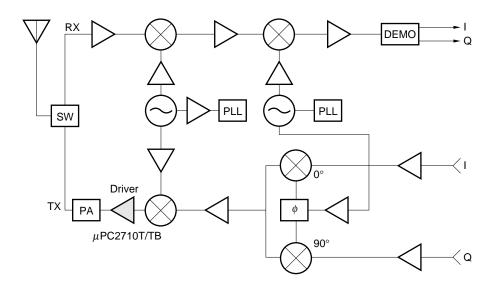
Part No.	f _u (GHz)	Po(sat) (dBm)	G _P (dB)	NF (dB)	Icc (mA)	Package	Marking
μPC2710T	1.0	+13.5	33	3.5	22	6-pin minimold	C1F
μPC2710TB	1.0	+13.5	33	3.5	22	6-pin super minimold	CIF

Remark Typical performance. Please refer to **ELECTRICAL CHARACTERISTICS** in detail.

Notice The package size distinguishes between minimold and super minimold.

SYSTEM APPLICATION EXAMPLE

EXAMPLE OF 900 MHz BAND DIGITAL CELLULER TELEPHONE





PIN EXPLANATION

Pin No.	Pin Name	Applied Voltage V	Pin Voltage V ^{Note}	Function and Applications	Internal Equivalent Circuit
1	INPUT	-	0.90	Signal input pin. A internal matching circuit, configured with resistors, enables $50~\Omega$ connection over a wide band. A multi-feedback circuit is designed to cancel the deviations of hFE and resistance. This pin must be coupled to signal source with capacitor for DC cut.	
4	OUTPUT	Voltage as same as Vcc through external inductor	-	Signal output pin. The inductor must be attached between Vcc and output pins to supply current to the internal output transistors.	© Vcc 4 OUT
6	Vcc	4.5 to 5.5	-	Power supply pin, which biases the internal input transistor. This pin should be externally equipped with bypass capacitor to minimize its impedance.	3 2 5 GND GND
2 3 5	GND	0	_	Ground pin. This pin should be connected to system ground with minimum inductance. Ground pattern on the board should be formed as wide as possible. All the ground pins must be connected together with wide ground pattern to decrease impedance difference.	

Note Pin voltage is measured at Vcc = 5.0 V



ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Conditions	Ratings	Unit
Supply Voltage	Vcc	T _A = +25°C, Pin 4 and 6	5.8	V
Total Circuit Current	Icc	T _A = +25°C	60	mA
Power Dissipation	P _D	Mounted on double copper clad $50 \times 50 \times 1.6$ mm epoxy glass PWB (T _A = +85°C)	280	mW
Operating Ambient Temperature	TA		-40 to +85	°C
Storage Temperature	T _{stg}		-55 to +150	°C
Input Power	Pin	T _A = +25°C	+10	dBm

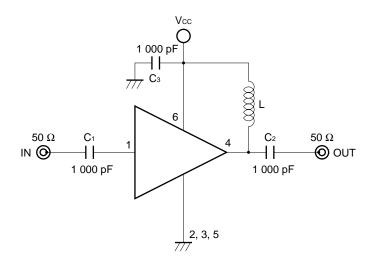
RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	MIN.	TYP.	MAX.	Unit	Notice
Supply Voltage	Vcc	4.5	5.0	5.5	V	The same voltage should be applied to pin 4 and 6.
Operating Ambient Temperature	TA	-40	+25	+85	°C	

ELECTRICAL CHARACTERISTICS (TA = +25°C, Vcc = Vout = 5.0 V, Zs = ZL = 50 Ω)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Circuit Current	Icc	No Signal	16	22	29	mA
Power Gain	G₽	f = 500 MHz	30	33	36.5	dB
Maximum Output Level	Po(sat)	f = 500 MHz, P _{in} = -8 dBm	+11	+13.5	-	dBm
Noise Figure	NF	f = 500 MHz	ı	3.5	5.0	dB
Upper Limit Operating Frequency	fu	3 dB down below flat gain at f = 0.1 GHz	0.7	1.0	_	GHz
Isolation	ISL	f = 500 MHz	34	39	-	dB
Input Return Loss	RLin	f = 500 MHz	3	6	-	dB
Output Return Loss	RLout	f = 500 MHz	9	12	-	dB
Gain Flatness	∆Gp	f = 0.1 to 0.6 GHz	_	±0.8	_	dB

TEST CIRCUIT



COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS

	Туре	Value
Сз	Capacitor	1 000 pF
L	Bias Tee	1 000 nH
C ₁ to C ₂	Bias Tee	1 000 pF

EXAMPLE OF ACTURAL APPLICATION COMPONENTS

	Туре	Value	Operating Frequency
C ₁ to C ₃	Chip Capacitor	1 000 pF	100 MHz or higher
L	Chip Inductor	300 nH	10 MHz or higher
		100 nH	100 MHz or higher
		10 nH	1.0 GHz or higher

INDUCTOR FOR THE OUTPUT PIN

The internal output transistor of this IC consumes 20 mA, to output medium power. To supply current for output transistor, connect an inductor between the Vcc pin (pin 6) and output pin (pin 4). Select large value inductance, as listed above.

The inductor has both DC and AC effects. In terms of DC, the inductor biases the output transistor with minimum voltage drop to output enable high level. In terms of AC, the inductor make output-port impedance higher to get enough gain. In this case, large inductance and Q is suitable.

CAPACITORS FOR THE Vcc, INPUT AND OUTPUT PINS

Capacitors of 1000 pF are recommendable as the bypass capacitor for the Vcc pin and the coupling capacitors for the input and output pins.

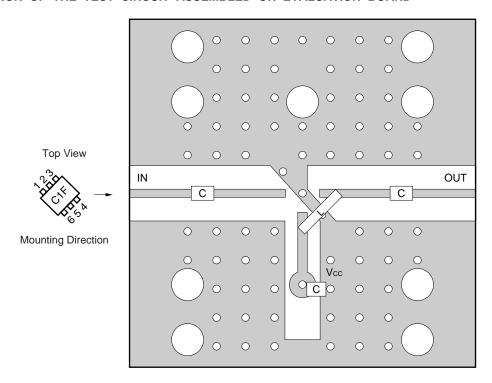
The bypass capacitor connected to the Vcc pin is used to minimize ground impedance of Vcc pin. So, stable bias can be supplied against Vcc fluctuation.

The coupling capacitors, connected to the input and output pins, are used to cut the DC and minimize RF serial impedance. Their capacitance are therefore selected as lower impedance against a 50 Ω load. The capacitors thus perform as high pass filters, suppressing low frequencies to DC.

To obtain a flat gain from 100 MHz upwards, 1000 pF capacitors are used in the test circuit. In the case of under 10 MHz operation, increase the value of coupling capacitor such as 10000 pF. Because the coupling capacitors are determined by equation, $C = 1/(2 \pi Rfc)$.



ILLUSTRATION OF THE TEST CIRCUIT ASSEMBLED ON EVALUATION BOARD



COMPONENT LIST

	Value
С	1 000 pF
L	300 nH

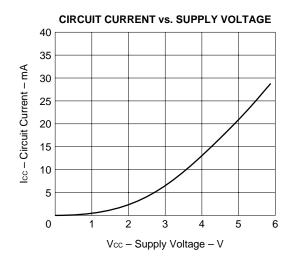
Notes

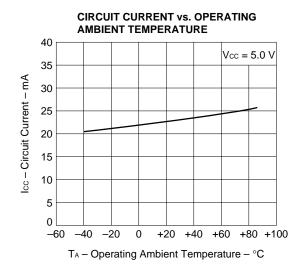
1. $30 \times 30 \times 0.4$ mm double sided copper clad polyimide board.

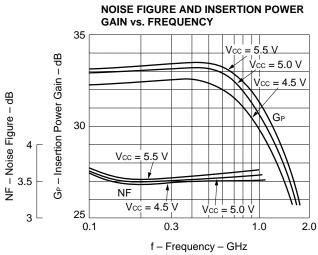
Back side: GND pattern
 Solder plated on pattern
 O O: Through holes

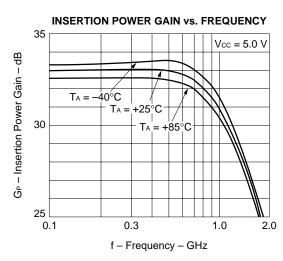
For more information on the use of this IC, refer to the following application note: USAGE AND APPLICATION OF SILICON MEDIUM-POWER HIGH-FREQUENCY AMPLIFIER MMIC (P12152E).

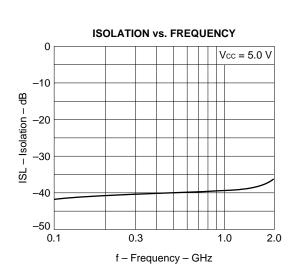
TYPICAL CHARACTERISTICS (Unless otherwise specified, TA = +25°C)

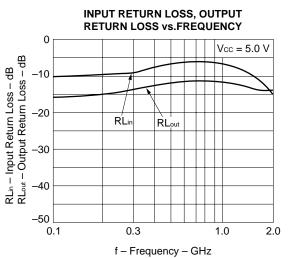


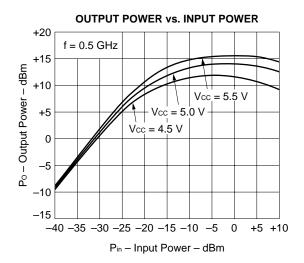


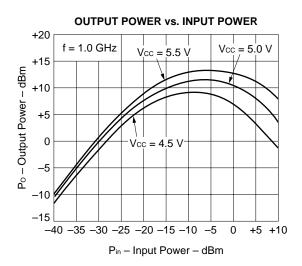


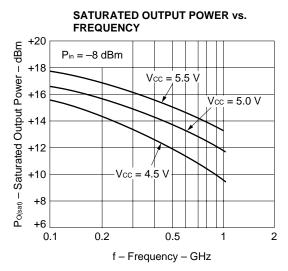


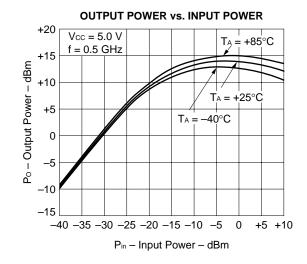


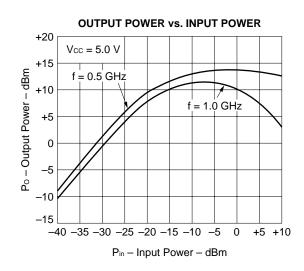


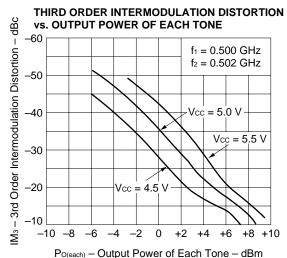






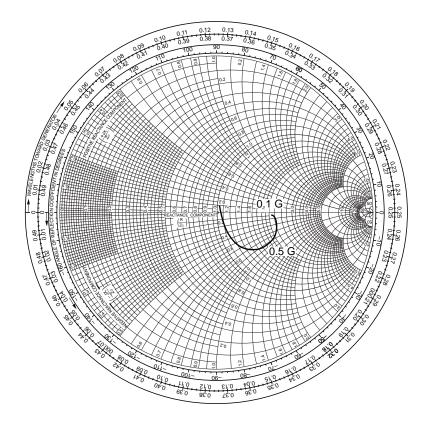




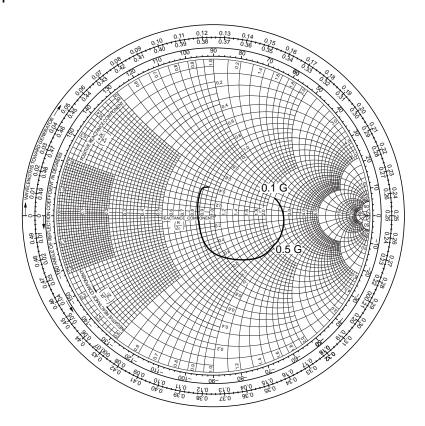


S-PARAMETER (Vcc = Vout = 5.0 V)

S₁₁-FREQUENCY



S₂₂-FREQUENCY





TYPICAL S-PARAMETER VALUES (TA = +25°C)

 μ PC2710T

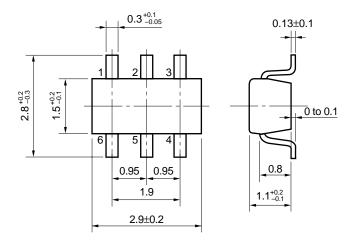
Vcc = Vout = 5.0 V, Icc = 21 mA

FREQUENCY	S	11	S	21	S	12	S	22	K
MHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
100.0000	.322	-0.3	37.668	-5.9	.013	17.1	.200	-11.7	1.06
200.0000	.346	3.3	38.808	-17.0	.012	19.8	.208	-15.4	1.07
300.0000	.383	2.1	40.192	-28.0	.009	22.5	.231	-23.5	1.21
400.0000	.429	-1.7	41.567	-40.4	.009	25.1	.258	-34.2	1.10
500.0000	.465	-9.4	42.130	-54.1	.012	27.8	.273	-47.2	0.86
600.0000	.486	-17.8	42.282	-68.3	.013	30.5	.305	-60.9	0.79
700.0000	.487	-27.2	41.075	-83.2	.013	33.1	.319	-77.8	0.82
800.0000	.468	-36.5	39.129	-97.9	.013	35.8	.320	-96.2	0.89
900.0000	.423	-44.5	35.399	-111.7	.013	38.5	.297	-115.4	1.04
1000.0000	.392	-50.3	32.933	-123.4	.014	41.2	.260	-128.2	1.10
1100.0000	.349	-56.6	30.025	-135.5	.014	43.9	.240	-142.2	1.22
1200.0000	.301	-61.0	26.823	-146.8	.015	46.6	.216	-156.3	1.31
1300.0000	.257	-63.2	23.836	-156.8	.016	49.2	.192	-169.7	1.40
1400.0000	.217	-63.5	21.128	-165.9	.016	51.6	.173	176.0	1.56
1500.0000	.184	-59.9	18.841	-174.2	.017	54.5	.155	162.3	1.65



PACAGE DIMENSIONS

6 pin minimold (Unit: mm)





NOTES ON CORRECT USE

- (1) Observe precautions for handling because of electro-static sensitive devices.
- (2) Form a ground pattern as wide as possible to minimize ground impedance (to prevent undesired oscillation). All the ground pins must be connected together with wide ground pattern to decrease impedance difference.
- (3) The bypass capacitor should be attached to Vcc line.
- (4) The inductor must be attached between Vcc and output pins. The inductance value should be determined in accordance with desired frequency.
- (5) The DC cut capacitor must be attached to input pin.

RECOMMENDED SOLDERING CONDITIONS

This product should be soldered under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your NEC sales representative.

μPC2710T

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared Reflow	Package peak temperature: 235°C or below Time: 30 seconds or less (at 210°C) Count: 3, Exposure limit ^{Note} : None	IR35-00-3
VPS	Package peak temperature: 215°C or below Time: 40 seconds or less (at 200°C) Count: 3, Exposure limit ^{Note} : None	VP15-00-3
Wave Soldering	Soldering bath temperature: 260°C or below Time: 10 seconds or less Count: 1, Exposure limit ^{Note} : None	WS60-00-1
Partial Heating	Pin temperature: 300°C Time: 3 seconds or less (per side of device) Exposure limit ^{Note} : None	-

Note After opening the dry pack, keep it in a place below 25°C and 65% RH for the allowable storage period.

Caution Do not use different soldering methods together (except for partial heating).

For details of recommended soldering conditions for surface mounting, refer to information document SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL (C10535E).

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systems, anti-crime systems, safety equipment and medical equipment (not specifically designed

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Anti-radioactive design is not implemented in this product.